

# Measurements of Dielectric Constant and Loss QuadTech 7000 Series LCR Meter & the Dielectric Products Type LD-3 Cell

This application note describes an integrated system for dielectric measurements on solid and liquid materials that includes the measurement instrument, the test cell, and the connecting cables and adapters. This setup allows rapid, precise measurements over a wide frequency range. The necessary cables are supplied with the 7000 Series instrument and the connectors, adapters, and the base plate are supplied with Dielectric Products Interface Kit, type LD-3-QT7000, which also includes a connection diagram.

The complete assembly is shown in the photograph in Figure 1. The shielded terminal of the LD-3 cell fixed electrode should be connected to the low terminals of the meter, both  $H_L$  and  $P_L$ , by means of the shielded cables, a Tee and GR-874 adapter (see photograph). The cable shields provide a ground to the body of the cell. The unshielded terminal on the barrel of the cell should be connected to the high terminals of the meter,  $I_H$  and  $P_H$ , with cables, a Tee and the banana pin adapter. The base plate keeps the cables from moving while the measurements are made which is particularly important at higher frequencies.



Figure1: QuadTech 7600 Precision LCR Meter connected to Dielectric Products LD-3 Cell

#### Procedures

Calibration - The 7000 Series instrument should have had a full calibration within its 1 year calibration interval. It should have a new OPEN circuit calibration performed, which, for best accuracy, be made at the test frequency to be used. To do this, remove the  $I_H$  and  $P_H$  leads from the cell (but keep them connected together) and move them a few inches from the H cell terminal, shielded from it by the body of the cell. The OPEN calibration should be performed using the procedure in the Operating Instructions for the 7000 Series instrument used.

A new SHORT circuit zero should also be made. At low frequencies simply plug the H plug (carefully) into the L connector and make the SHORT calibration. However, above 10 kHz, don't move the leads, but rather place a soft metal such as folded aluminum foil between the active electrodes and close the electrodes until contact is made. Do not contact the guard ring.

Procedure (See Measurement Methods) - These dielectric measurements require a series of two or more capacitance and dissipation factor measurements from which the relative dielectric constant (K or  $\varepsilon_r$ ) and dissipation factor (D) of the sample can be calculated. The procedures are outlined on the following pages along with their formulas. Further information on these measurements is available on the GR Application Note #11 (provided with the LD-3 cell), ASTM Standard D-150 and IEC Standard 250.

Computer Programs - Dielectric measurements require precision calculations and are greatly facilitated by computer programs. Simple programs are easily written for manually entered data. Programs for automatic data transfer from the 7000 Series instruments require reference to the instruction manuals for these instruments. QuadTech has developed windows based applications software which performs the measurement techniques described. This software utilizes the 7000 Series LCR Meters via RS-232 interface. Contact QuadTech for further information.

Accuracy - The accuracy of the measurements of dielectric properties depends on the procedures used, the two-fluid method being most accurate, and on the accuracy of the separate capacitance and dissipation factor measurements. The latter depend on the test conditions as shown in the operation instructions for the instrument used but may be substantially better than the specifications given, particularly if calibrations are made at the test frequency to be used and if several measurements are averaged to increase precision.

# Definitions

Many different notations are used for dielectric properties, see references above. This application note will use **K**, the relative dielectric constant, and **D**, the dissipation factor (or tan  $\delta$ ) defined as follows:

$$K = \varepsilon_r' = \varepsilon_r$$
 and  $D = \tan \delta = \varepsilon_r'' / \varepsilon_r'$ 

The complex relative permittivity is

$$\varepsilon_r^* = \varepsilon/\varepsilon_o = \varepsilon_r' - j\varepsilon_r''$$

where  $\varepsilon_0$  is the permittivity of a vacuum, and  $\varepsilon$  the absolute permittivity.

 $\varepsilon_o = 0.08854 \,\mathrm{pF/cm}$ 

The capacitance of a parallel-plate air capacitor (two plates) is

 $C = K_a \varepsilon_o Area / spacing$ 

where  $K_a$  is the dielectric constant of air

 $K_a = 1.00053$ 

if the air is dry and at normal atmospheric pressure.

Permittivity ( $\epsilon$ ) is the dielectric constant multiplied by the dielectric constant of empty space ( $\epsilon_0$ ), where the permittivity of empty space ( $\epsilon_0$ ) is a constant appearing in Coulomb's Law, having a value of 1 in centimeter-gram-second electrostatic units, and of 8.854 x 10<sup>-12</sup> farad/meter in rationalized meter-kilogram-second units.\*

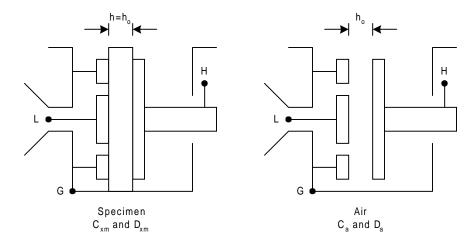
A Dielectric is a material which is an electrical insulator or in which an electric field can be sustained with a minimum dissipation of power.\*

Dielectric Constant of a material is defined in electrical terms for an isotropic medium, as the ratio of the capacitance of a capacitor filled with a given dielectric to that of the same capacitor having only a vacuum as a dielectric.\*

\* McGraw-Hill Dictionary of Scientific and Technical Terms, 1974 McGraw-Hill, Inc

## Measurement Methods: Solids

The Contacting Electrode Method is quick and easy, but is the least accurate. The results for K should be within 10% if the sample is reasonably flat.



**Figure 2: Contact Method** 

First the sample is inserted in the cell and the electrodes closed with the micrometer until they just touch the sample. Do not force the electrodes against the sample. Turn the micrometer with a light finger touch. Record the electrometer setting as  $h_{m}$ . Set the instrument to measure *parallel* capacitance and measure the capacitance and dissipation factor of the sample as  $C_{xm}$  and  $D_{xm}$ .

Open the electrodes and remove the sample. Then close the electrodes to the same micrometer reading,  $h_m$ . Measure C (parallel) and D of empty cell as  $C_a$  and  $D_a$ .

Calculate  $K_x$  and  $D_x$  of the sample from:

 $K_x = (1.0005) C_{xm}/C_a$  and  $D_x = D_{xm} - D_a$ 

The factor 1.0005 in the formula for  $K_x$  corrects for the dielectric constant of (dry) air. Subtracting  $D_a$  from  $D_{xm}$  removes any constant phase error in the instrument. For even better D accuracy, adjust the electrode spacing until the measured capacitance is approximately equal to  $C_{xm}$  and then measure  $D_a$ .

Note that both  $K_X$  and  $D_X$  will probably be too low because there is always some air between the electrodes and the sample. This error is smallest for very flat samples, for thicker samples and for those with low K and D values.

## Air Gap Method

The Air-Gap Method avoids the error due to the air layer but requires that the thickness of the sample is known. Its thickness should be measured at several points over its area and the measured values should be averaged to get the thickness h. The micrometer used should have the same units as those of the micrometer on the cell.

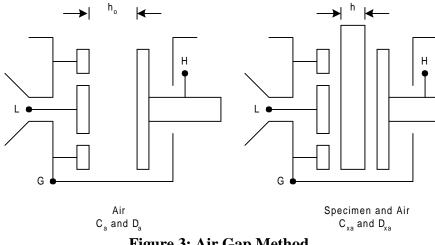


Figure 3: Air Gap Method

Set the electrodes to about .02 cm or .01 inch greater than the sample thickness, h, and measure the equivalent series capacitance and D, as Ca and Da. Note the micrometer setting as hm and correct this with the micrometer zero calibration, hmo (see Appendix A), to get

$$h_o = h_m + h_{mo}$$

Then insert the sample and measure it as  $C_{xa}$  and  $D_{xa}$ . Calculate

$$M = (h_o - h)/h_o$$
$$D_x = (D_{xa} - D_a) \left(\frac{C_a}{C_a - MC_{xa}}\right)$$

and

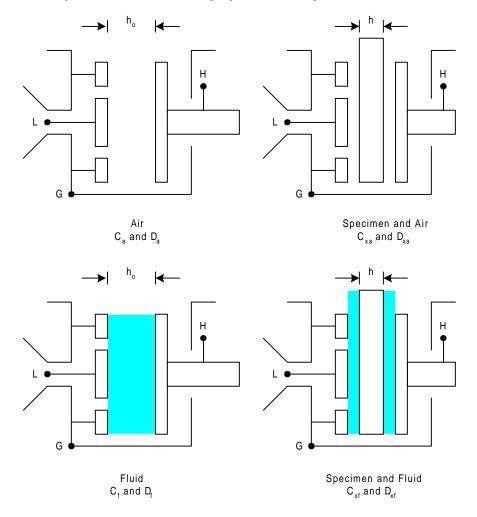
$$K_{x} = \left(\frac{(1 - M)C_{xa}}{C_{a} - MC_{xa}}\right) \left(\frac{1.0005}{1 + D_{x}^{2}}\right)$$

The factor  $(1 + D_x^2)$  converts the series value of  $C_x$  to the equivalent parallel value and is not necessary if D<sub>x</sub> is small. The factor of 1.0005 corrects for the dielectric constant of air (if dry). The formula for  $D_X$  assumes that the true D of air is zero and it makes a correction for a constant D error in the instrument.

# The Two Fluid Method

The Two-Fluid Method is preferred for specimens whose thickness is difficult to measure and for best accuracy which will be limited by the accuracy of the C and D measurements. However it requires four measurements, two using a second fluid (the first being air). The dielectric properties of this fluid need not be known, but it must not react with the specimen and it must be stable and safe to use. A silicone fluid such as Dow Corning 200, 1 centistoke viscosity, is most generally satisfactory.

The four measurements of *series* capacitance and D are outlined in the figure below. Note the spacing is the same for all measurements and should be just slightly more than the specimen thickness. The accuracy will be limited mainly by the accuracy of the measurements made.





From these measurements calculate

$$\frac{\mathbf{h}}{\mathbf{h}_{o}} = 1 - \frac{\mathbf{C}_{a}\mathbf{C}_{f}(\mathbf{C}_{xf} - \mathbf{C}_{xa})}{\mathbf{C}_{xa}\mathbf{C}_{xf}(\mathbf{C}_{f} - \mathbf{C}_{a})} \text{ and } \qquad \frac{\mathbf{C}_{xser}}{\mathbf{C}_{a}} = \frac{\mathbf{C}_{xf}\mathbf{C}_{xa}(\mathbf{C}_{f} - \mathbf{C}_{a})}{\mathbf{C}_{a}(\mathbf{C}_{xa}\mathbf{C}_{f} - \mathbf{C}_{xf}\mathbf{C}_{a})}$$

which is the ratio of the equivalent series capacitance of the sample to  $C_a$ . If  $D_x$  is close to  $D_f$  or larger use

$$D_{x} = D_{xf} + \frac{C_{a}(C_{xf} - C_{xa})(D_{xf} - D_{f})}{C_{xa}C_{f} - C_{xf}C_{a}}$$

If  $D_x$  is very small use

$$D_{x} = \frac{(D_{xa} - D_{a})C_{xf}(C_{f} - C_{a})}{C_{xa}C_{f} - C_{xf}C_{a}}$$

which makes a zero D correction.

From the above results calculate

$$\mathbf{K}_{\mathrm{x}} = \left(\frac{\mathbf{h}}{\mathbf{h}_{\mathrm{o}}}\right) \left(\frac{\mathbf{C}_{\mathrm{xser}}}{\mathbf{C}_{\mathrm{a}}}\right) \left(\frac{1.0005}{1 + \mathbf{D}_{\mathrm{x}}^{2}}\right)$$

As before, the factor of 1.0005 corrects for the dielectric constant of air (if dry) and the  $(1 + D_x^2)$  factor converts  $C_x$  to equivalent parallel capacitance.

Measurement Methods: Liquids

Measurements on liquids are simple, the only difficulty is with handling and cleanup. Measure equivalent *parallel* capacitance and D first of air ( $C_a$  and  $D_a$ ) and then of the liquid to be measured ( $C_{xm}$  and  $D_{xm}$ ), then determine

$$K_{x} = \frac{C_{xm}}{C_{a}} (1.0005)$$

and

 $D_x = D_{xm} - D_a$ 

Note that the spacing is not critical but should be narrow enough to make the capacitance large enough to be measured accurately.

Other liquid cells are available that are easier to clean and use a smaller sample (as listed in Appendix B).

# Appendices

## Appendix A: Micrometer Zero Calibration

The micrometer zero correction may change with used. To check this, measure the capacitance of the empty cell with a narrow setting,  $h_1$ , getting  $C_1$ , and with a wider setting,  $h_2$ , getting  $C_2$ . The value of the zero offset,  $h_{mo}$ , is

$$h_{mo} = \frac{h_2 C_2 - h_1 C_1}{C_1 - C_2}$$

Greater accuracy is obtained by taking measurements at more spacings and averaging the results.

## Appendix B: Accessories

Available from Dielectric Products Company\*:

Interface Cable Set High Temperature Cell LD-3T High temperature Cable Set Dielectric Cell Top Cover LD-3-TC Thermocouple & Fitting Teflon standard TS-100 Liquid Cell 350 Powder and Paste Cell MC-100 Resistivity Cell RF-100

\* Dielectrics Products Co. 178 Orchard Street, Watertown, MA 02172 617-924-5688

For complete product specifications on the 7000 Series Precision LCR meters or any of QuadTech's products, visit us at <u>http://www.quadtech.com/products</u>. Do you have an application specific testing need? Call us at 1-800-253-1230 or email your questions to <u>info@quadtech.com</u>.

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Telephone: 1- 800-253-1230, Website: http://www.quadtech.com			
	Printed in U.S.A.	P/N 035012/A2	August 2003